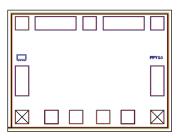
Fast Switching

SPDT RF Switch Die M3SWA-250DRBD+

DC to 4500 MHz, Absorptive Switch with internal driver 50Ω .

The Big Deal

- High Isolation, 56 dB typ.
- High Input IP3, +46.5 dBm typ
- Low insertion loss, 0.6 dB typ
- Fast Rise/Fall time, 3.3 ns / 4.6 ns typ.



Product Overview

Mini-Circuits' M3SWA-250DRBD+ is a MMIC SPDT absorptive switch die with an internal driver designed for wideband operation from DC to 4.5 GHz supporting many applications requiring fast switching across a wide frequency range. This model provides excellent isolation, fast switching speed and high linearity.

Key Features

Feature	Advantages
Wideband, DC to 4.5 GHz	One model can be used in many applications, saving component count. Also ideal for wideband applications such as military and instrumentation.
Absortive Switch	In the OFF condition, RF output ports which are not switched ON are terminated into 50Ω . This enables proper impedance termination of the cirucitry following the RF output ports, preventing any unintended action such as oscillation.
High Isolation: • 62 dB at 1000 MHz • 35 dB at 4500 MHz	High isolation significantly reduces leakage of power into OFF ports.
High linearity: Input power at P1dB, 25.4 dBm typ. Input IP3, +46.5 dBm typ.	High linearity minimizes unwanted intermodulation products which are difficult or impossible to filter in multi-carrier environments such as CATV, or in the presence of strong interfering signal from adjacent circuitry or received by antenna.
Unpackaged die	Enables user to integrate it directly into hybrids.

Fast Switching

PDT RF Switch Die M3SWA-250DRBD+

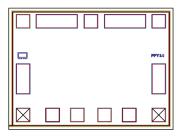
 50Ω . DC to 4500 MHz, Absorptive Switch with internal driver

Product Features

- High Isolation, 56 dB typ.
- Low insertion loss, 0.6 dB typ.
- Fast Rise/Fall time, 3.3 ns / 4.6 ns typ.
- High Input IP3, +46.5 dBm typ.

Typical Applications

- Defense
- · Communication Infrastructure
- Test and Measurements



+RoHS Compliant

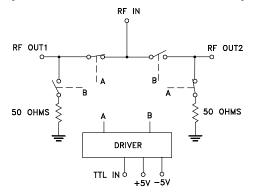
The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

General Description

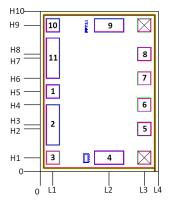
Mini-Circuits' M3SWA-250DRBD+ is a MMIC SPDT absorptive switch die with an internal driver designed for wideband operation from DC to 4.5 GHz supporting many applications requiring fast switching across a wide frequency range. This model provides excellent isolation, fast switching speed and high linearity.

Simplified Schematic and Pad description



Pad#	Function		
1	RF-IN		
3	V _{EE}		
4	RF OUT 1		
6	TTL		
7	TTL GROUND		
9	RF OUT 2		
10	VDD		
2,5,8,11	GROUND		

Bonding Pad Position



	Dimensions in pin, Typical												
L2	L3	L4	H1	H2	НЗ	H4	H5	H6	H7	Н8	H9	H10	
408	617	700	83	254	278	397	475	554	673	697	867	950	

Thickness	Die size	Pad Size 1,3,5,6,7,8 & 10	Pad size 2&11	Pad size 4&9
100	700 x 950	74 x 74	74 x 234	169x74

L1

76

RF Electrical Specifications¹, T_{AMB}=25°C, 50Ω, V_{DD}= +5V, V_{EE}= -5V

Parameter	Condition (MHz)	Min.	Тур.	Max.	Units
Frequency Range ³		DC		4500	MHz
	10-100		0.5		
	100-1000		0.5		
Insertion Loss	1000-2000		0.6		dB
	2000-4000		0.7		
	4000-4500		1.4		
	10-100		78		
	100-1000		59		
Isolation between Output Port 1 & 2	1000-2000		49		dB
	2000-4000		39		
	4000-4500		32		
	10-100		97		
	100-1000		75		
Isolation between Common Port & Output Ports	1000-2000		56		dB
	2000-4000		43		
	4000-4500		36		
	10-100		29		
	100-1000		30		
Input Return Loss	1000-2000		27		dB
	2000-4000		23		
	4000-4500		22		
	10-100		29		
0.1.18.1.1	100-1000		28		
Output Return Loss (Both ON STATE & OFF STATE)	1000-2000		22		dB
(BOILTON STATE & OFF STATE)	2000-4000		19		
	4000-4500		14		
	10-100		19.2		
	100-1000		24.5		
Input Power at P1dB ²	1000-2000		25.4		dBm
	2000-4000		25.0		
	4000-4500		23.8		
	10-100		39.7		
	100-1000		44.7		
Input IP3 (Pout =0dBm/Tone)	1000-2000		46.5		dBm
	2000-4000		44.0		
	4000-4500		40.1		
Thermal Resistance (Junction-to-ground Lead at 85°C stage temperature)			34.2		degC/W

DC Electrical Specifications

Parameter	Min.	Тур.	Max.	Units	
Positive Supply Voltage, V _{DD}	4.75	5	5.25	V	
Negative Supply voltage, V _{EE}	-5.25	-5	-4.75	V	
Positive Supply Current, IDD	_	5	9	mA	
Negative Supply Current, IEE	-9	-3	_	mA	
Control Voltage Low	_	0	0.8	V	
Control Voltage High	2.1	2.3	5	V	
Control Current Low	_	0	0.2	mA	
Control Current High	_	0.4	5	mA	

- Notes: 1. Die is packaged in 3.25×3.25 mm, 8-lead MCLP package and soldered on TB-M3SWA250DRB+. 2. Input Power at P1dB compression drops to 13 dBm at 10 MHz.
- 3. All RF-ports must be DC blocked or held at 0V DC.

Switching Specifications

Parameter	Condition	Min.	Тур.	Max.	Units
ON Time, 50% control to 90% RF	RF Pin= 0 dBm RF Freq.= 500 MHz Control Freq.= 500 KHz		14.4		ns
OFF Time, 50% control to 10% RF			11.3		ns
Video Leakage			42.5		mV
Rise Time, 10% RF to 90% RF 10 to 90% or 90 to 10%	Control High= 2.3V Control Low= 0V		3.3		ns
Fall Time, 90% RF to 10% RF	CONTROL LOW = UV		4.6		ns

Absolute Maximum Ratings⁴

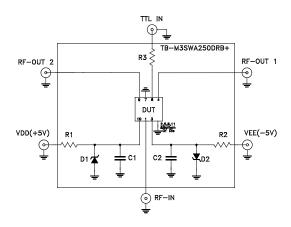
Parameter	Ratings
Operating temperature	-55°C to +100°C
RF Input power	+24 dBm
Junction Temperature	134°C
Total Power Dissipation	0.4W
DC Voltage, Pad 10	+6V
DC Voltage, Pad 3	-6V

Permanent damage may occur if any of these limits are exceeded. Electrical Maximum ratings are not intended for continuous normal operation.

Truth Table

State of Control Voltage	RF-IN to RF-OUT1	RF-IN to RF-OUT 2
LOW	ON	OFF
HIGH	OFF	ON

Characterization & Application Circuit



Component	Size	Value	P/N	Manufacturer
DUT	3.25x3.25	N/A	M3SW-2-50DRA+	MCL
D1, D2	SOD-123	Vz = 5.6V	MMSZ4690T1G	ON Semiconductor
R1, R2	0603	11.5Ω	RK73H1JTTD11R5F	KOA
R3	0603	100Ω	RK73H1JTTD1000F	KOA
C1, C2	0603	10pF	06031A100GAT2A	AVX

Note: D1&D2 are optional.

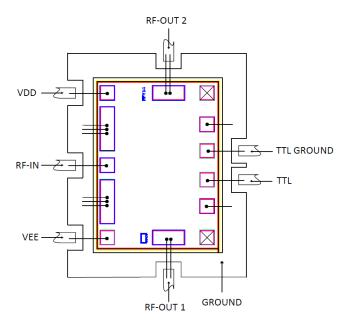
Figure 1. Characterization & Application Circuit

Note: (DUT is packaged in 3.25x3.25mm, 8-lead MCLP package and soldered on Mini-Circuits Characterization & Application Test Board TB-M3SWA250DRB+). Insertion Loss, Amplitude Unbalance, Isolation, Return Loss, Input Power at 1dB Compression (P1dB) & Input IP3 tested using E5071C microwave network analyzer.

Condition:

- 1. Insertion Loss, Amplitude Unbalance, Isolation & Return Loss: Pin = 0dBm
- 2. Input IP3(IIP3):Two tones, spaced 1 MHz apart, 0dBm/tone output.

Assembly Diagram



Assembly and Handling Procedure

1. Storage

Dice should be stored in a dry nitrogen purged desiccators or equivalent.

2. ESD

MMIC SPDT Absorptive Switch dice are susceptible to electrostatic and mechanical damage. Dice are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.

Die Attach

The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.

4. Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

Additional Detailed Technical Information

additional information is available on our dash board.

	Data Table				
Performance Data	Swept Graphs				
	S-Parameter (S2P Files) Data Set with an	nd without port extension(.zip file)			
Case Style	Die				
	Quantity, Package	Model No.			
Die Ordering and packaging information	Small, Gel - Pak: 5,10,50,100 KGD* Medium [†] , Partial wafer: KGD*<1880 Large [†] , Full Wafer	M3SWA-250DRBDG+ M3SWA-250DRBDP+ M3SWA-250DRBDF+			
	†Available upon request contact sales representative				
Refer to AN-60-067					
Environmental Ratings	ENV80				

*Known Good Dice ("KGD") means that the dice in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such dice fall within a predefined range. While DC testing is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

ESD Rating**

Human Body Model (HBM): Class 0 (Pass 100V) in accordance with ANSI/ESD STM 5.1 - 2001

Additional Notes

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
- B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.
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^{**} Tested in industry standard MCLP 3.25x3.25 mm, 8-lead package.